Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination YAMAZAKI ET AL.	
09/873,311		
Examiner	Art Unit	
Nhan T. Tran	2622	

SEARCHED					
Class	Subclass	Date	Examiner		
		-			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

DATE	
DATE	EXMR
7/9/2006	NT
7/9/2006	NT